
Atmel AVR116: Wear Leveling on DataFlash

32-bit Atmel Microcontrollers

Features

- Wear leveling
 - Average the program/erase operations in different blocks
- Write not need be preceded by an erase operation
- Redirect logical address from host system to physical address in flash memory
- Power loss recovery
- Support FAT file system

Description

Flash memory has a limited program/erase cycle, program and erase in a same block many times will result in bad blocks and decrease the flash memory life cycle dramatically.

Flash memory is not fit for sector-based file systems (fat, etc.). Flash memory has several characteristics that make difficult straightforward replacement of magnetic disks. First, a write in flash memory should be preceded by an erase operation, which takes an order of magnitude longer than a write operation. Second, erase operations can only be performed in a much larger unit than the write operation. This implies that, for an update of even a single byte, an erase operation as well as restoration of a large amount of data would be required. This not only degrades the potential performance significantly, but also gives rise to an integrity problem since data may be lost if the power goes down unexpectedly during the restoration process.

An intermediate software layer called flash translation layer (FTL) addresses the above mentioned issues. It enables the file systems access flash memory as access magnetic disks and prolong the flash memory life cycle.

This application note will help the user to use the FTL interface.

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1. Abbreviations and definitions

- FTL: Flash Translation Layer
- HAL: Hardware Abstract Layer
- sector Logical unit, 512Bytes
- page Physical unit, actual page size of the Atmel® DataFlash®

2. Related parts

FTL library can be applied to the following parts:

2.1 Atmel AT25DFx series

- AT25DF641A
- AT25DF641
- AT25DF321A
- AT25DF321
- AT25DF161
- AT25DF081A
- AT25DF041A

2.2 Atmel AT45DBx series

- AT45DB642D
- AT45DB321D
- AT45DB161D

3. FTL library

3.1 Introduction

FTL redirects the logical address from uplayer to physical address in flash memory, and average the program/erase operation in different blocks.

FTL features the function of wear leveling, bad block management, garbage collection, defrag and power loss recovery. It fully supports FAT file system.

Due to different features of the AT25DFx series and AT45DBx series DataFlash, two libraries have been implemented respectively. Most of the two libraries are the same; the only difference for user is the hal layer interface. This will be detailed in Section [3.3.3](#).

The footprint of FTL library is about 6Kbyte. The RAM usage depends on the block number.

Atmel AT25DFx series:

Take AT25DF321A as an example. Its size is 4Mbyte and use 64K as a FTL blocks. The maximum RAM usage is 2Kbyte.

Approximately, the RAM usage is 1.1Kbyte + 14 × (block number - used block).

Atmel AT45DBx series:

Take AT45DB642D as an example. Its size is 8Mbyte and use 64K as a FTL block. The maximum RAM usage is 4.1Kbytes.

Approximately, the RAM usage is 2.1Kbyte + 16 × (block number - used block).

3.2 Architecture

FTL is divided into three parts, up layer, ftl and hal. [Figure 3-1](#) illustrates the architecture. [Figure 3-2](#) shows briefly the redirection of the logical address from uplayer to physical address in flash.

Figure 3-1. FTL architecture.

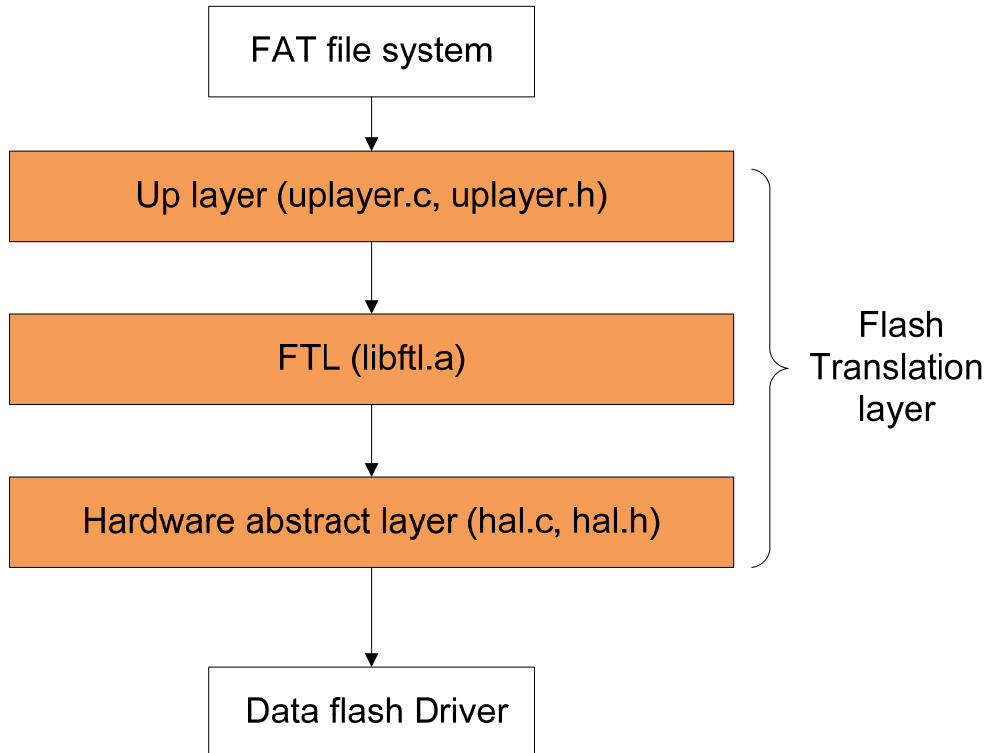
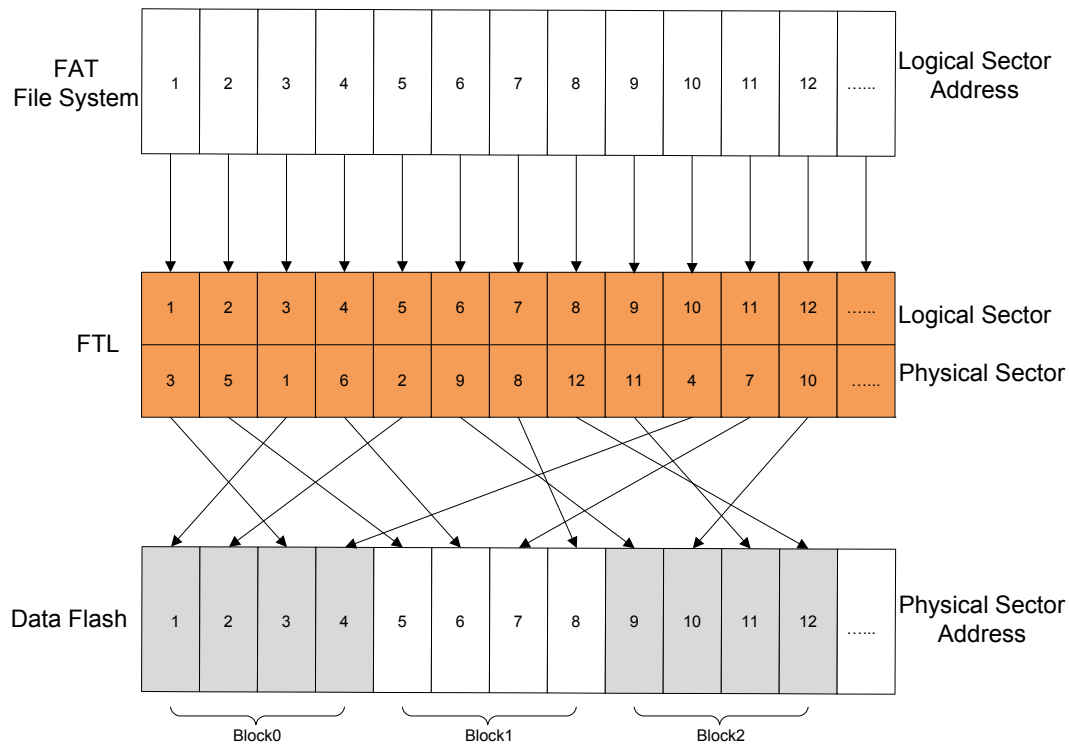


Figure 3-2. FTL redirect logical address to physical address.



3.3 Interface

3.3.1 Up layer

This layer provides the interface for FAT file system.

- `uplayer_status_t test_unit_ready(void)`
 - This function is used to check memory state

Argument	Type	Comment
None	-	-

Return value	Comment
<code>UPLAYER_SUCCESS</code>	Memory is ready
<code>UPLAYER_UNIT_NO_PRESENT</code>	Memory is not ready

- `uplayer_status_t read_capacity(uint32_t *nb_sectors)`
 - This function is used to read memory capacity

Argument	Type	Comment
<code>nb_sector</code>	<code>uint32_t*</code>	Pointer to the variable which store the number of sectors

Return value	Comment
<code>UPLAYER_SUCCESS</code>	Read memory capacity successful
<code>UPLAYER_FAILURE</code>	Read memory capacity fail

- bool **test_wr_protect**(void)
 - This function is used to check memory if write protect

Argument	Type	Comment
None	-	-

Return value	Comment
true	Memory is write protect
false	Memory is not write protect

- bool **test_unit_removal**(void)
 - This function is used to check memory if be removed

Argument	Type	Comment
None	-	-

Return value	Comment
true	Memory is removed
false	Memory is not removed

- uplayer_status_t **ram_2_df**(uint32_t sector, void *ram)
 - This function is used to write one page data to memory

Argument	Type	Comment
sector	uint32_t	The logical sector number
ram	void*	RAM to store one sector (512bytes) data write to memory

Return value	Comment
UPLAYER_SUCCESS	Write memory with one sector data successful
UPLAYER_FAILURE	Write memory with one sector data fail

- uplayer_status_t **df_2_ram**(uint32_t sector, void *ram)
 - This function is used to read one page data from memory

Argument	Type	Comment
sector	uint32_t	The logical sector number
ram	void*	RAM to store one sector (512bytes) data read from memory

Return value	Comment
UPLAYER_SUCCESS	Read memory with one sector data successful
UPLAYER_FAILURE	Read memory with one sector data fail

All the routines are described in uplayer.h file.

3.3.2 FTL

This layer provides interfaces for uplayer, and can also be called directly when you don't want to use FAT.

- ftl_status_t **ftl_init**(void)
 - This function is used to initialize ftl structure

Argument	Type	Comment
None	-	-

Return value	Comment
FTL_INIT_SUCCESS	FTL structure initialization successful
FTL_INIT_FAILURE	FTL structure initialization fail

Note: This routine will erase all the contents of the memory when FTL has not been used before on this memory.

- `ftl_status_t ftl_read(uint32_t sector, uint8_t *buf)`
 - This function is used to read one page data from memory

Argument	Type	Comment
sector	uint32_t	The logical sector number
buf	uint8_t*	Buf to store one sector (512bytes) data read from memory

Return value	Comment
FTL_READ_PAGE_SUCCESS	Read memory with one sector data successful
FTL_READ_PAGE_FAILURE	Read memory with one sector data fail

- `ftl_status_t ftl_write(uint32_t sector, uint8_t *buf)`
 - This function is used to write one page data to memory

Argument	Type	Comment
sector	uint32_t	The logical sector number
buf	uint8_t*	Buf to store one sector (512bytes) data write to memory

Return value	Comment
FTL_WRITE_PAGE_SUCCESS	Write memory with one sector data successful
FTL_WRITE_PAGE_FAILURE	Write memory with one sector data fail

- `ftl_status_t ftl_test_unit_ready(void)`
 - This function is used to test memory state

Argument	Type	Comment
None	-	-

Return value	Comment
FTL_UINT_READY	Memory is ready
FTL_UINT_NOT_READY	Memory is not ready

- `ftl_status_t ftl_read_capacity(uint32_t *nb_sectors)`
 - This function is used to read memory capacity

Argument	Type	Comment
nb_sectors	uint32_t*	Pointer to the variable which store the number of sectors

Return value	Comment
FTL_READ_CAPACITY_SUCCESS	Read memory capacity successful
FTL_READ_CAPACITY_FAILURE	Read memory capacity fail

- `ftl_status_t ftl_test_unit_wr_protect(void)`
 - This function is used to test memory write protect state

Argument	Type	Comment
None	-	-

Return value	Comment
FTL_UNIT_WR_PROTECT	Memory is write protect
FTL_UNIT_WR_NO_PROTECT	Memory is not write protect

- `ftl_status_t ftl_unit_unprotect(void)`
 - This function is used to unprotect memory

Argument	Type	Comment
None	-	-

Return value	Comment
<code>FTL_UNIT_UNPROTECT_SUCCESS</code>	Unprotect memory successful
<code>FTL_UNIT_UNPROTECT_FAILURE</code>	Unprotect memory fail

- `ftl_status_t ftl_test_unit_removal(void)`
 - This function is used to test memory if be removed

Argument	Type	Comment
None	-	-

Return value	Comment
<code>FTL_UNIT_REMOVAL</code>	Memory is removed
<code>FTL_UNIT_NO_REMOVAL</code>	Memory is not removed

Note: Use `ftl_read_capacity(...)` to get the available number of sectors.
All the routines are described in `ftl.h` file.

3.3.3 Hardware abstract layer

This layer provides interfaces for FTL. The routines in this layer will call data flash drivers which implemented by user. The address arguments are all physical address in this layer.

3.3.3.1 Atmel AT25DFx series DataFlash

- `ftl_status_t hal_block_erase(uint32_t addr)`
 - This function is used to erase memory block

Argument	Type	Comment
<code>addr</code>	<code>uint32_t</code>	The physical address of the memory block to erase

Return value	Comment
<code>FTL_BLOCK_ERASE_SUCCESS</code>	Memory block erase successful
<code>FTL_BLOCK_ERASE_FAILURE</code>	Memory block erase fail

Note: The block erase unit is 64Kbyte block.

- `ftl_status_t hal_read_id(uint8_t *buf)`
 - This function is used to read memory id

Argument	Type	Comment
<code>buf</code>	<code>uint8_t*</code>	Buf (4bytes) used to store memory ID

Return value	Comment
<code>FTL_GET_CHIP_ID_SUCCESS</code>	Get memory ID successful
<code>FTL_GET_CHIP_ID_FAILURE</code>	Get memory ID fail

- **ftl_status_t hal_set_block_status**(uint32_t addr, uint8_t *buf, uint16_t count)
 - This function is used to set block status

Argument	Type	Comment
addr	uint32_t	The physical address of the memory to write the bytes
buf	uint8_t*	Buf to store the data write to memory
count	uint16_t	Number of bytes need to write

Return value	Comment
FTL_SET_BLOCK_STATUS_SUCCESS	Write successfully
FTL_SET_BLOCK_STATUS_FAILURE	Write fail

- **ftl_status_t hal_get_block_status**(uint32_t addr, uint8_t *buf, uint16_t count)
 - This function is used to get the block status

Argument	Type	Comment
addr	uint32_t	The physical address of the memory to read the bytes
buf	uint8_t*	Buf to store the data read from memory
count	uint16_t	Number of bytes need to read

Return value	Comment
FTL_GET_BLOCK_STATUS_SUCCESS	Read successfully
FTL_GET_BLOCK_STATUS_FAILURE	Read fail

- **ftl_status_t hal_write_page**(uint32_t sector, uint8_t *buf)
 - This function is used to write one sector data to memory

Argument	Type	Comment
sector	uint32_t	The physical sector number
buf	uint8_t*	Buf to store one sector (512bytes) data write to memory

Return value	Comment
FTL_WRITE_PAGE_SUCCESS	Write memory with one sector data successful
FTL_WRITE_PAGE_FAILURE	Write memory with one sector data fail

- **ftl_status_t hal_read_page**(uint32_t sector, uint8_t *buf)
 - This function is used to read one sector data from memory

Argument	Type	Comment
sector	uint32_t	The physical sector number
buf	uint8_t*	Buf to store one page (512bytes) data read from memory

Return value	Comment
FTL_READ_PAGE_SUCCESS	Read memory with one sector data successful
FTL_READ_PAGE_FAILURE	Read memory with one sector data fail

- **ftl_status_t hal_test_unit_wr_protect**(void)
 - This function is used to test memory if write protect

Argument	Type	Comment
None	-	-

Return value	Comment
FTL_UNIT_WR_PROTECT	Memory is write protect
FTL_UNIT_WR_NO_PROTECT	Memory is not write protect

- `ftl_status_t hal_unit_unprotect(void)`
 - This function is used to unprotect memory

Argument	Type	Comment
None	-	-

Return value	Comment
<code>FTL_UNIT_UNPROTECT_SUCCESS</code>	Unprotect memory successful
<code>FTL_UNIT_UNPROTECT_FAILURE</code>	Unprotect memory fail

- `ftl_status_t hal_test_unit_removal(void)`
 - This function is used to test if memory be removed

Argument	Type	Comment
None	-	-

Return value	Comment
<code>FTL_UNIT_REMOVAL</code>	Memory is removed
<code>FTL_UNIT_NO_REMOVAL</code>	Memory is not removed

3.3.3.2 Atmel AT45DBx series DataFlash

- `ftl_status_t hal_read_id(uint8_t *buf)`
 - This function is used to read memory id

Argument	Type	Comment
buf	<code>uint8_t*</code>	Buf (4bytes) used to store memory ID

Return value	Comment
<code>FTL_GET_CHIP_ID_SUCCESS</code>	Get memory ID successful
<code>FTL_GET_CHIP_ID_FAILURE</code>	Get memory ID fail

- `ftl_status_t hal_set_block_status(uint32_t addr, uint8_t *buf, uint16_t count)`
 - This function is used to set block status

Argument	Type	Comment
addr	<code>uint32_t</code>	The physical address of the memory to write the bytes
buf	<code>uint8_t*</code>	Buf to store the data write to memory
count	<code>uint16_t</code>	Number of bytes need to write

Return value	Comment
<code>FTL_SET_BLOCK_STATUS_SUCCESS</code>	Write successfully
<code>FTL_SET_BLOCK_STATUS_FAILURE</code>	Write fail

- `ftl_status_t hal_get_block_status(uint32_t addr, uint8_t *buf, uint16_t count)`
 - This function is used to get the block status

Argument	Type	Comment
addr	<code>uint32_t</code>	The physical address of the memory to read the bytes
buf	<code>uint8_t*</code>	Buf to store the data read from memory
count	<code>uint16_t</code>	Number of bytes need to read

Return value	Comment
<code>FTL_GET_BLOCK_STATUS_SUCCESS</code>	Read successfully
<code>FTL_GET_BLOCK_STATUS_FAILURE</code>	Read fail

- `ftl_status_t hal_set_page_status(uint32_t addr, uint8_t *buf, uint16_t count)`
 - This function is used to set page status

Argument	Type	Comment
<code>addr</code>	<code>uint32_t</code>	The physical address of the memory to write the bytes
<code>buf</code>	<code>uint8_t*</code>	Buf to store the data write to memory
<code>count</code>	<code>uint16_t</code>	Number of bytes need to write

Return value	Comment
<code>FTL_SET_BLOCK_STATUS_SUCCESS</code>	Write successfully
<code>FTL_SET_BLOCK_STATUS_FAILURE</code>	Write fail

- `ftl_status_t hal_get_page_status(uint32_t addr, uint8_t *buf, uint16_t count)`
 - This function is used to get page status

Argument	Type	Comment
<code>addr</code>	<code>uint32_t</code>	The physical address of the memory to read the bytes
<code>buf</code>	<code>uint8_t*</code>	Buf to store the data read from memory
<code>count</code>	<code>uint16_t</code>	Number of bytes need to read

Return value	Comment
<code>FTL_GET_BLOCK_STATUS_SUCCESS</code>	Read successfully
<code>FTL_GET_BLOCK_STATUS_FAILURE</code>	Read fail

- `ftl_status_t hal_write_page(uint32_t sector, uint8_t *buf, bool spare)`
 - This function is used to write one sector data to memory

Argument	Type	Comment
<code>sector</code>	<code>uint32_t</code>	The physical sector number
<code>buf</code>	<code>uint8_t*</code>	Buf to store one sector (512bytes) data write to memory
<code>spare</code>	<code>bool</code>	Write sector with spare or not

Return value	Comment
<code>FTL_WRITE_PAGE_SUCCESS</code>	Write memory with one sector data successful
<code>FTL_WRITE_PAGE_FAILURE</code>	Write memory with one sector data fail

- `ftl_status_t hal_read_page(uint32_t sector, uint8_t *buf, bool spare)`
 - This function is used to read one sector data from memory

Argument	Type	Comment
<code>sector</code>	<code>uint32_t</code>	The physical sector number
<code>buf</code>	<code>uint8_t*</code>	Buf to store one sector (512bytes) data read from memory
<code>spare</code>	<code>bool</code>	Read sector with spare or not

Return value	Comment
<code>FTL_READ_PAGE_SUCCESS</code>	Read memory with one page data successful
<code>FTL_READ_PAGE_FAILURE</code>	Read memory with one page data fail

- `ftl_status_t hal_test_unit_wr_protect(void)`
 - This function is used to test memory if write protect

Argument	Type	Comment
<code>None</code>	-	-

Return value	Comment
<code>FTL_UNIT_WR_PROTECT</code>	Memory is write protect
<code>FTL_UNIT_WR_NO_PROTECT</code>	Memory is not write protect

- `ftl_status_t hal_unit_unprotect(void)`
 - This function is used to unprotect memory

Argument	Type	Comment
None	-	-

Return value	Comment
<code>FTL_UNIT_UNPROTECT_SUCCESS</code>	Unprotect memory successful
<code>FTL_UNIT_UNPROTECT_FAILURE</code>	Unprotect memory fail

- `ftl_status_t hal_test_unit_removal(void)`
 - This function is used to test if memory be removed

Argument	Type	Comment
None	-	-

Return value	Comment
<code>FTL_UNIT_REMOVAL</code>	Memory is removed
<code>FTL_UNIT_NO_REMOVAL</code>	Memory is not removed

All the routines are described in the `hal.h` file.

This layer should be implemented by the user. Users need to use this layer to perform a full test of their DataFlash driver.

3.4 Error control

All the routines return a status which is described in `ftl_status.h`. Using these statuses we can locate where the error happen easily.

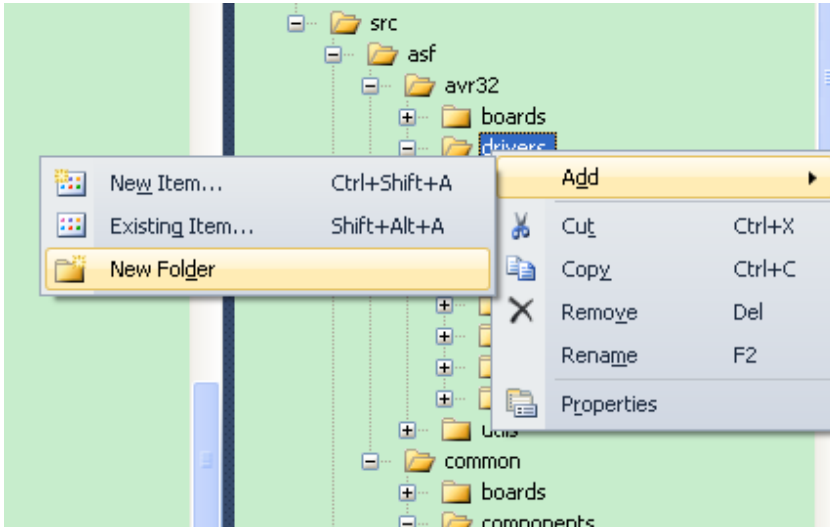
The routines in `uplayer.c` return a status which is known by FAT.

4. Usage

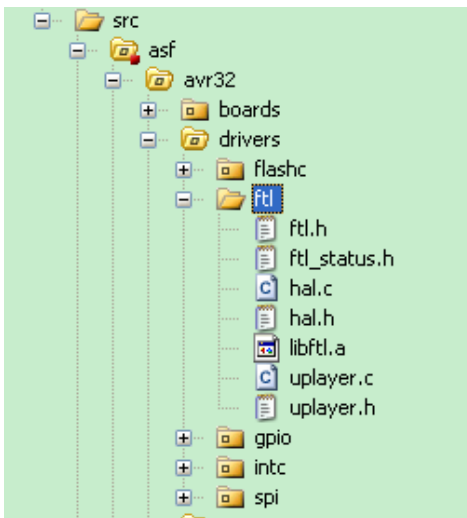
All examples and test cases are tested in Atmel Studio 6.0.

4.1 Integrate library to your project

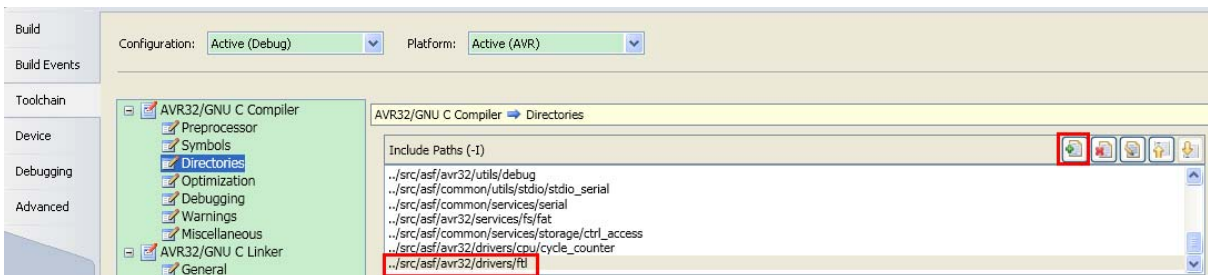
1. Create a new folder in your project; you can create this folder under drivers.

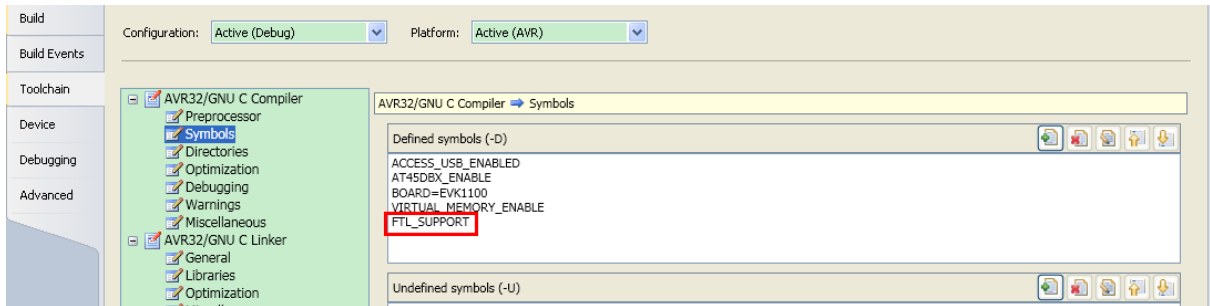
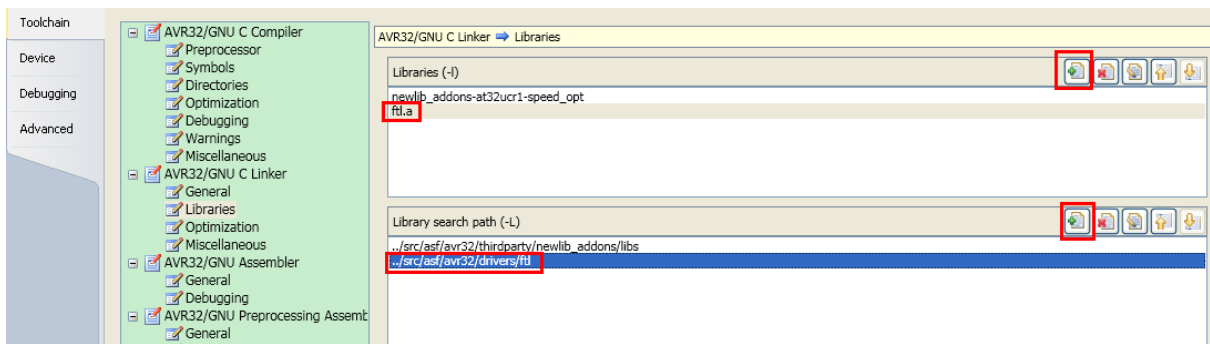


2. Add the FTL library files to this folder. Here we create a new folder ftl under drivers.



3. Set the search path for toolchains and enable FTL_SUPPORT. Right click on the project, select Properties.





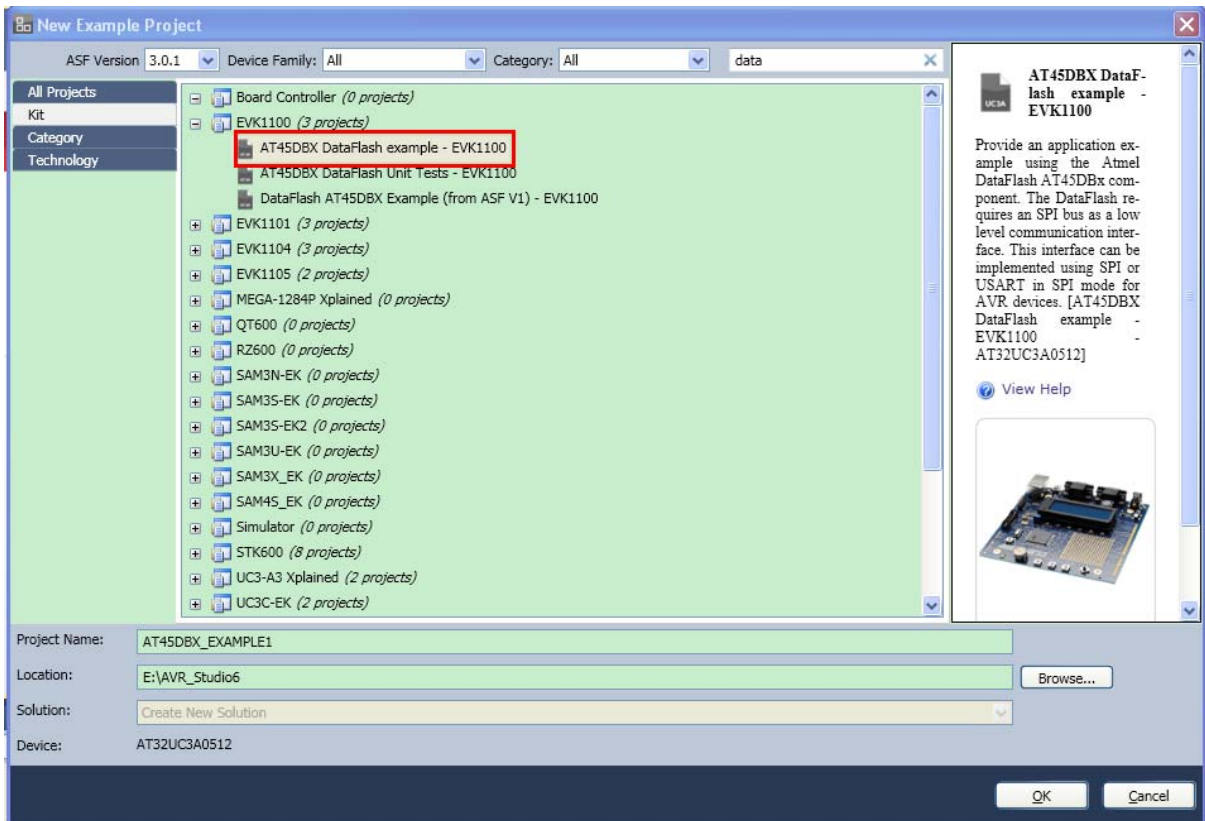
4. Add low level data flash driver (at25dfx.c/h or at45dbx.c/h) to your project. If these files have already existed in your project, just replace them.

Note: Make sure the data flash can work (etc. read/write ok) before using FTL library.

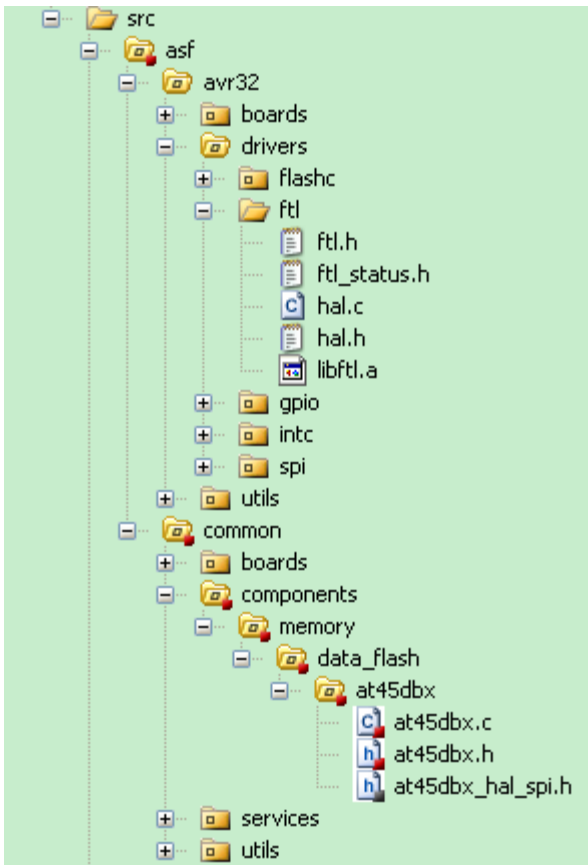
4.2 Example with Atmel EVK1100

This section details a quick way to test the FTL functionality. The step-by-step procedure is as follow:

1. Create a new AT45DBX DataFlash example.



2. Add FTL library to project. This step has been detailed in Section 4.1.



3. Add FTL functionality test routine in file at45dbx_example.c.

```
#include "ftl.h"
int main(void)
{
    uint16_t i;
    sysclk_init();

    // Initialize the board.
    // The board-specific conf_board.h file contains the configuration of the board
    // initialization.
    board_init();
    at45dbx_init();
    if(at45dbx_mem_check()==true) {
        gpio_set_pin_low(DATA_FLASH_LED_EXAMPLE_0);
    } else
    {
        test_ko();
    }
    //ADD FTL functionality test here
    test_case_1();
    |
    // Prepare half a data flash sector to 0xAA
    for(i=0;i<AT45DBX_SECTOR_SIZE/2;i++) {
        ram_buf[i]=0xAA;
    }
    // And the remaining half to 0x55
    for(;i<AT45DBX_SECTOR_SIZE;i++) {
        ram_buf[i]=0x55;
    }
}
```



```

bool test_case_1(void)
{
    uint32_t i;
    ftl_status_t status;
    uint8_t page_buf[512];

    //We need call ftl_init() before we use FTL
    ftl_init();

    //Here we write 400Mbytes to page 0 of dataflash
    //to test ftl read/write and wear leveling
    for(i = 0; i < 819200; i++){ // 400MByte data

        memset(page_buf,0xaa,512);
        //Write one page data to sector number 0
        status = ftl_write(0, page_buf);
        if(status != FTL_WRITE_PAGE_SUCCESS) {
            print_dbg("Write fail!\r\n");
            return false;
        }

        memset(page_buf,0,512);
        //Read one page data from sector number 0
        status = ftl_read(0, page_buf);
        if(status != FTL_READ_PAGE_SUCCESS) {
            print_dbg("Read fail!\r\n");
            return false;
        }
        //Verify the data write and read
        if(compare_buf(0xaa, page_buf)){
            print_dbg("Verify fail!\r\n");
            return false;
        }
    }
    return true;
}

```

Note: Routine `ftl_init()` should be called firstly when the FTL is used.

If you use the FTL the first time, the routine `ftl_init()` will erase the entire chip. You should be careful if there are some important data in the chip.

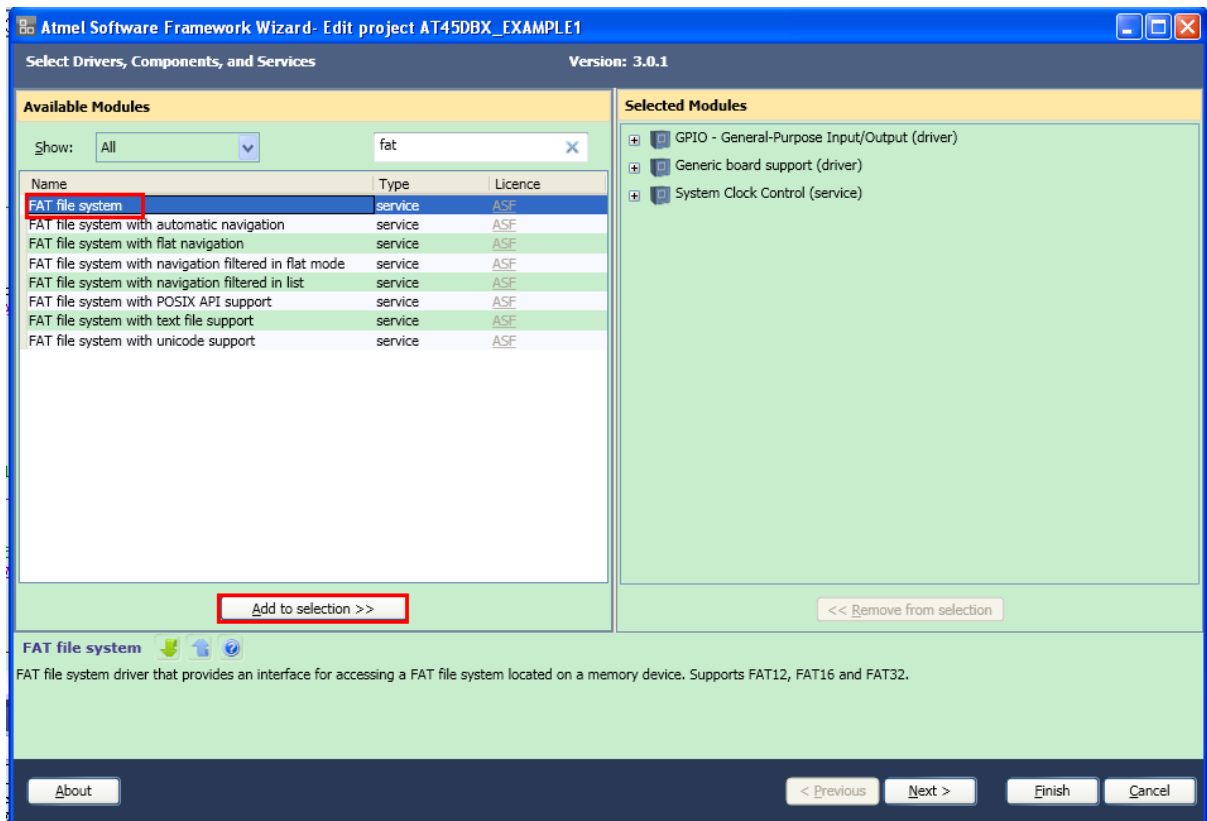
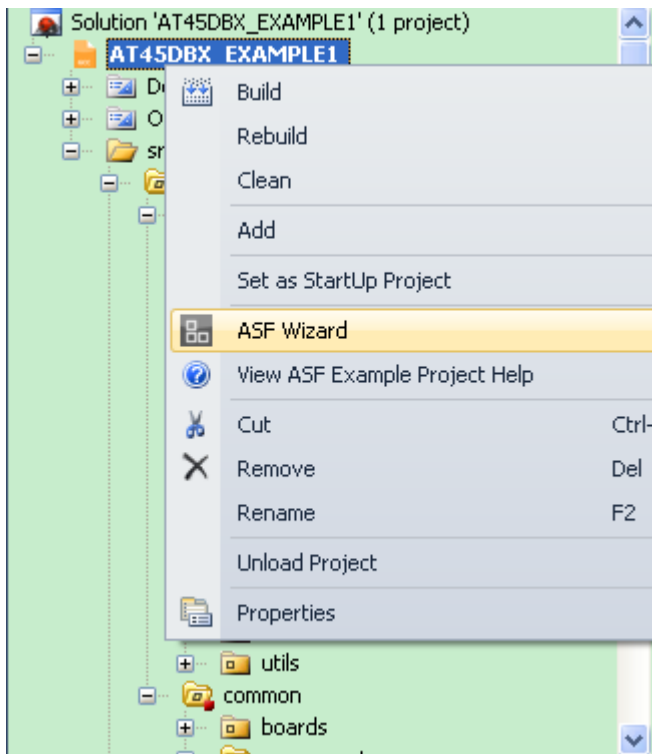
4. All things are done now. The only thing left is to compile the source code.

4.3 Using FTL through FAT

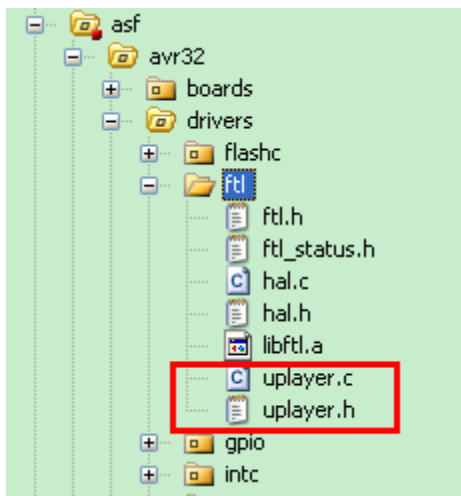
This section details a quick way to test the FTL functionality through FAT interface.

Based on the Atmel EVK1100 AT45DBX Example, which is detailed in Section 4.2, the step by step procedure is as follow:

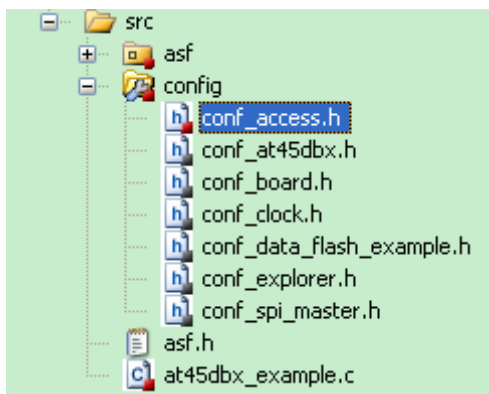
1. Add FAT service to the project.



2. Add FTL uplayer.c and uplayer.h to the ftl folder.



3. Add FTL uplayer interface for FAT in config/conf_access.h.



```

/*! name LUN 1 Definitions
*/
/*! @{
= #ifdef FTL_SUPPORT
#define AT45DBX_MEM LUN_1
#define LUN_ID_AT45DBX_MEM LUN_ID_1
#define LUN_1_INCLUDE "uplayer.h"
#define Lun_1_test_unit_ready test_unit_ready
#define Lun_1_read_capacity read_capacity
#define Lun_1_wr_protect test_wr_protect
#define Lun_1_removal test_unit_removal
#define Lun_1_usb_read_10 usb_read_10
#define Lun_1_usb_write_10 usb_write_10
#define Lun_1_mem_2_ram df_2_ram
#define Lun_1_ram_2_mem ram_2_df
#define LUN_1_NAME "\AT45DBX Data Flash\"
# else
#define AT45DBX_MEM LUN_1
#define LUN_ID_AT45DBX_MEM LUN_ID_1
#define LUN_1_INCLUDE "at45dbx_mem.h"
#define Lun_1_test_unit_ready at45dbx_test_unit_ready
#define Lun_1_read_capacity at45dbx_read_capacity
#define Lun_1_wr_protect at45dbx_wr_protect
#define Lun_1_removal at45dbx_removal
#define Lun_1_usb_read_10 at45dbx_usb_read_10
#define Lun_1_usb_write_10 at45dbx_usb_write_10
#define Lun_1_mem_2_ram at45dbx_df_2_ram
#define Lun_1_ram_2_mem at45dbx_ram_2_df
#define LUN_1_NAME "\AT45DBX Data Flash\"
# endif

```

4. Change FAT feature level in file config/conf_explorer.h.

```

///! Level of features.
///! Select among:
///! - c FSFEATURE_READ: All read functions.
///! - c FSFEATURE_WRITE: nav_file_copy(), nav_file_paste(), nav_file_
///! - c FSFEATURE_WRITE_COMPLET: FSFEATURE_WRITE functions and nav_drive_form
///! - c FSFEATURE_ALL: All functions.
#define FS_LEVEL_FEATURES (FSFEATURE_READ | FSFEATURE_WRITE_COMPLET)
#warning "FAT Level of Features set to None by default: edit the conf_explorer.h

```

5. Enable stream memory to memory interface to make compile pass.

```

#define ACCESS_STREAM true //!< Streaming MEM <-> MEM interface.
#define ACCESS_STREAM_RECORD false //!< Streaming MEM <-> MEM interface in record mode.
#define ACCESS_MEM_TO_MEM true //!< MEM <-> MEM interface.
#define ACCESS_CODEC false //!< Codec interface.
/*! @}

```

6. Add test routine in the at45dbx_example.c file and include asf.h in this file.

```

//Each file 1MByte size
#define NB_WRITE    2000L
#define BUF_SIZE    512L
bool test_case_2(void) //test ftl under fat
{
    uint16_t i, cnt;
    uint32_t index = 100;
    uint8_t page_buf[BUF_SIZE]; //Buf used to write
    uint8_t read_buf[BUF_SIZE]; //Buf used to read

    uint8_t *name[3] = {"data1", "data2", "data3"};

    if(!mount_fat()) { //format Dataflash and mount fat
        printf("Mount fat fail!\r\n");
        return false;
    }
    memset(page_buf, 0xa5, 512);

    while(index--){
        //Write file data1, data2, data3, each file 1Mbytes
        for(i = 0; i < 3; i++){
            printf("File: %s created\r\n", name[i]);
            if(!nav_file_create((const FS_STRING)name[i])) {
                printf("Create file: %s fail\r\n", name[i]);
                return false;
            }
            if(!file_open(FOPEN_MODE_W)) {
                printf("Open file: %s for write fail\r\n", name[i]);
                return false;
            }
            for(cnt = 0; cnt < NB_WRITE; cnt++){
                if(!file_write_buf(page_buf, BUF_SIZE)) {
                    file_close();
                    printf("File write fail: %s\r\n", name[i]);
                    return false;
                }
            }
            file_close();
            //Read back to verify it
            if(!file_open(FOPEN_MODE_R)) {
                printf("Open file: %s for read fail\r\n", name[i]);
                return false;
            }
            while (file_eof()==false) {
                file_read_buf(read_buf, BUF_SIZE);
                if(compare_buf(0xa5, read_buf)) {
                    printf("Verify file %s fail!\r\n", name[i]);
                    file_close();
                    return false;
                }
            }
            file_close();
            printf("File: %s write OK, file size: %dMByte\r\n\r\n", name[i], 1);
        }
        // Delete file data1, data2, data3, then we can write them in next loop
        if(!file_delete()) {
            printf("File delete fail!\r\n");
            return false;
        }
    }
    return true;
}

```

```

//Format dataflash and mount fat
void mount_fat()
{
    nav_reset();
    //Select navigator 0
    if(!nav_select(0)) {
        printf("Nav select fail \r\n");
        return false;
    }
    //Navigator select the dataflash driver
    if(!nav_drive_set(0)) {
        printf("Nav drive set fail\r\n");
        return false;
    }
    //Format dataflash
    if( !nav_drive_format(FS_FORMAT_DEFAULT) ) {
        printf("Format fail!\r\n");
        return false;
    }
    //Mount dataflash
    if(!nav_partition_mount()) {
        printf("Partition mount fail\r\n");
        return false;
    }
}

```

```

//Delete files
bool file_delete()
{
    uint8_t name[3] = {"data1","data2","data3"};
    uint8_t i;
    for(i = 0; i < 3; i++) {
        //Select the file to be deleted
        if(!nav_setcwd( (FS_STRING)name[i], true, false)) {
            printf("Nav setcwd: %s fail\r\n", name[i]);
            return false;
        }
        //File delete
        if(!nav_file_del( false )) {
            printf("File: %s delete fail\r\n", name[i]);
            return false;
        }

        printf("File: %s deleted \r\n", name[i]);
    }
}

```

5. Performance

FTL wear leveling performance is tested on the Atmel DataFlash AT45DB642D. This performance can also be applied to the Atmel AT25DFx series DataFlash.

Figure 5-1 shows the wear leveling on the DataFlash AT45DB642D. This result was got through 400Mbytes data writing in the same page of the DataFlash using FTL interface.

X-axis value is block number and Y-axis value is erase count in different blocks.

Figure 5-1. Wear leveling on the Atmel AT45DB642D using FTL interface.

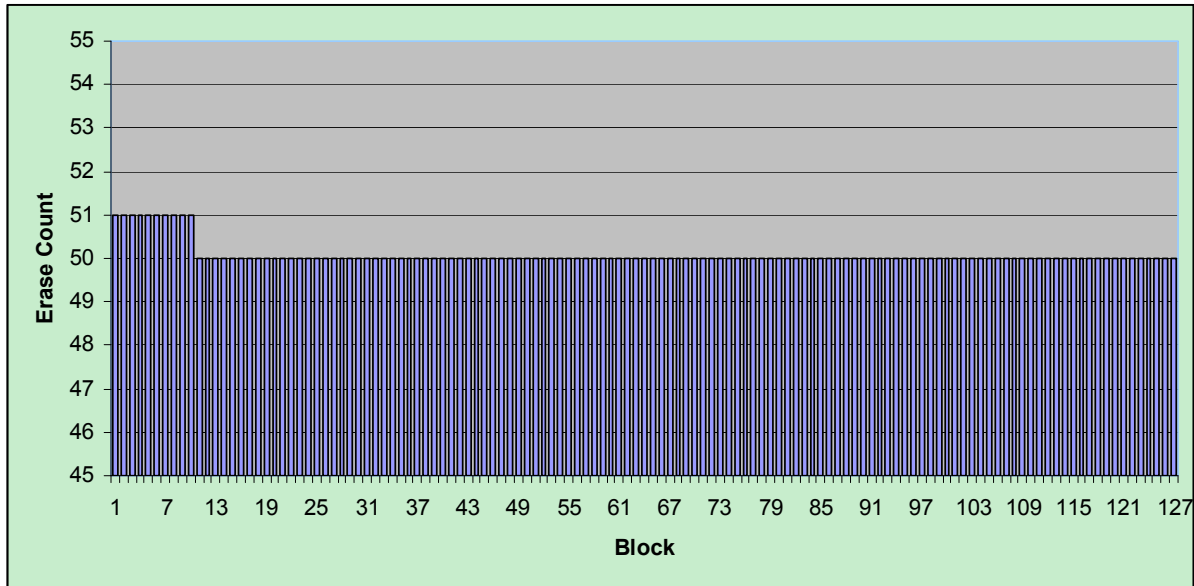
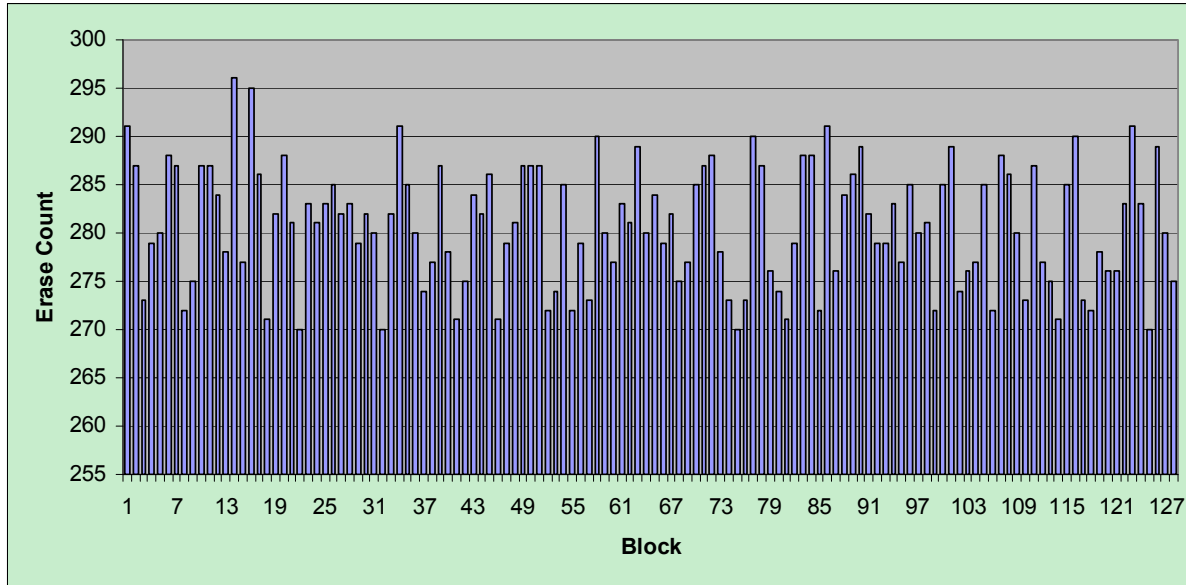


Figure 5-2 shows the wear leveling on the DataFlash AT45DB642D after about 400MByte data write through FAT interfaces.

X-axis value is block number and Y-axis value is erase count in different blocks.

Figure 5-2. Wear leveling on the Atmel AT45DB624D using FAT interfaces.



FTL divides DataFlash lifecycle to four levels (for example, AT45DB642D 100,000 times program/erase life cycles, each level has 25,000 program/erase cycles). The block will not be used when its erase count gets up to the first level while other blocks' erase counts are still below 25,000. Free blocks are allocated by round robin scheduling again when all the blocks get up to the first level. This process is going on till the blocks get its end life cycle.

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